

STF12N50DM2

N-channel 500 V, 0.299 Ω typ., 11 A MDmesh™ DM2 Power MOSFET in a TO-220FP package

Datasheet - production data

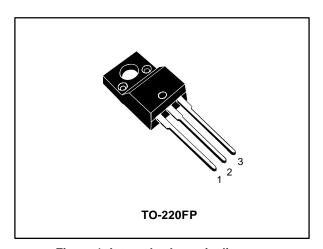
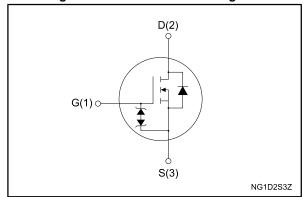


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ID
STF12N50DM2	500 V	0.350 Ω	11 A

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmesh DM2 fast recovery diode series. It offers very low recovery charge and time (Qrr, trr) combined with low R_{DS(on)}, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STF12N50DM2	12N50DM2	TO-220FP	Tube

Contents STF12N50DM2

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STF12N50DM2 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _G s	Gate-source voltage	±25	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	11	۸
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	8	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	44	Α
Ртот	Total dissipation at T _C = 25 °C	25	W
dv/dt (3)	Peak diode recovery voltage slope	40	V/ns
dv/dt (4)	MOSFET dv/dt ruggedness	50	V/ns
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s, T_C = 25 °C)	2500	V
T _{stg}	Storage temperature range	-55 to 150	°C
Tj	Operating junction temperature range	-55 10 150	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	5	°C/W
R _{thj-amb}			C/VV

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by T_{jmax})	2.5	Α
Eas	Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR} , V_{DD} = 50 V)	320	mJ

⁽¹⁾Limited by maximum junction temperature.

⁽²⁾Pulse width limited by safe operating area.

 $^{^{(3)}}$ IsD \leq 11 A, di/dt \leq 400 A/µs; VDS peak < V(BR)DSS, VDD = 80% V(BR)DSS

 $^{^{(4)}}$ V_{DS} ≤ 400 V

Electrical characteristics STF12N50DM2

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified).

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	500			V
	Zoro goto voltago	V _{GS} = 0 V, V _{DS} = 500 V			1	μΑ
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 500 \text{ V},$ $T_{C} = 125 \text{ °C}^{(1)}$			100	μΑ
Igss	Gate-body leakage current	V _{DS} = 0 V, V _{GS} = ±25 V			±10	μΑ
V _{GS(th)}	Gate threshold voltage	V _{DS} = V _{GS} , I _D = 250 μA	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 5.5 A		0.299	0.350	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	628	-	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	38	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	1.2	-	pF
Coss eq. (1)	Equivalent output capacitance	V _{DS} = 0 V to 400 V, V _{GS} = 0 V	-	69	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	7	-	Ω
Qg	Total gate charge	$V_{DD} = 400 \text{ V}, I_{D} = 11 \text{ A},$	-	16	-	nC
Q_gs	Gate-source charge	V _{GS} = 10 V (see <i>Figure 15: "Test</i>	-	4.6	-	nC
Q_{gd}	Gate-drain charge	circuit for gate charge behavior")	-	7	-	nC

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V _{DD} = 250 V, I _D = 5.5 A	-	12.5	-	ns
tr	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Figure 14: "Test circuit for	-	9	-	ns
t _{d(off)}	Turn-off-delay time	resistive load switching times"	ı	28	1	ns
t _f	Fall time	and Figure 19: "Switching time waveform")	-	9.8	-	ns



⁽¹⁾Defined by design, not subject to production test.

 $^{^{(1)}}$ $C_{\text{oss eq.}}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isp	Source-drain current		-		11	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		44	Α
V _{SD} ⁽²⁾	Forward on voltage	V _G S = 0 V, I _{SD} = 11 A	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 11 A, di/dt = 100 A/μs,	1	140		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load switching and diode recovery	-	0.707		μC
I _{RRM}	Reverse recovery current	times")	1	10.1		Α
t _{rr}	Reverse recovery time	I _{SD} = 11 A, di/dt = 100 A/μs,	-	190		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V, T _i = 150 °C (see Figure 16: "Test circuit for inductive load switching and	-	1.111		μC
IRRM	Reverse recovery current	diode recovery times")	-	11.7		Α

Notes:

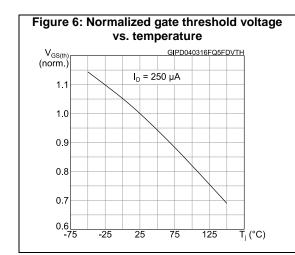
⁽¹⁾Pulse width is limited by safe operating area

 $^{^{(2)}\}text{Pulse}$ test: pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

Electrical characteristics

2.1 Electrical characteristics (curves)

Figure 2: Safe operating area GIPD040316FQ5FFSOA I_D (A) Operation in this a limited by max. R 10¹ t_p= 10 μs t_p= 100 μs 10⁰ t_p= 1 ms T_i≤ 150 °C T_c= 25 °C t_p= 10 ms single pulse 10-1 10¹ $\vec{V}_{DS}(V)$ 10° 10²



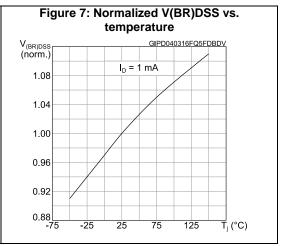


Figure 8: Static drain-source on-resistance

R_{DS(on)}
(Ω)

0.31

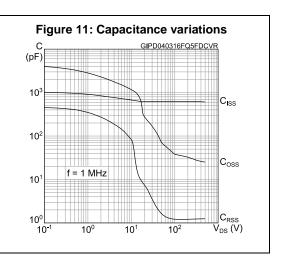
V_{GS} = 10 V

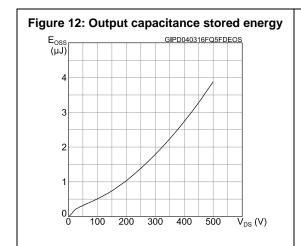
0.29

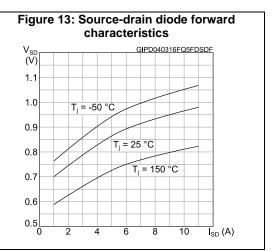
0.28

0 2 4 6 8 10 I_D (A)

Figure 10: Gate charge vs. gate-source voltage GIPD040316FQ5FDQVG V_{DS} (V) V_{GS} (V) V_{DD} = 400 V 12 600 $I_{D} = 11 A$ 10 500 8 400 300 200 100 __0 Q_g (nC)







Test circuits STF12N50DM2

3 Test circuits

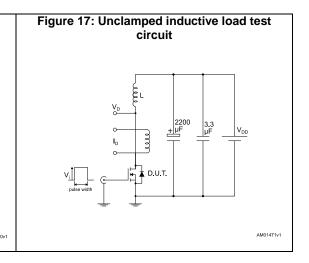
Figure 14: Test circuit for resistive load switching times

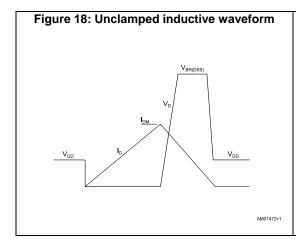
Figure 15: Test circuit for gate charge behavior

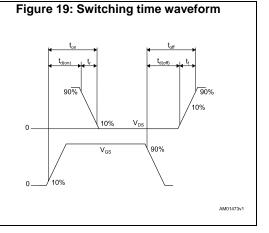
12 V 47 KQ 100 nF D.U.T.

2200 VG AM01468v1

Figure 16: Test circuit for inductive load switching and diode recovery times







STF12N50DM2 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



4.1 TO-220FP package information

Figure 20: TO-220FP package outline

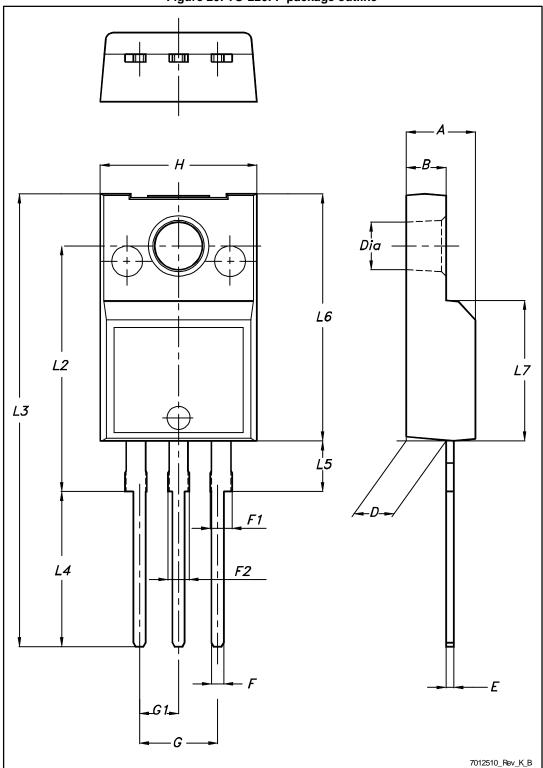


Table 9: TO-220FP package mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

Revision history STF12N50DM2

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
26-Aug-2014	1	First release.
07-Mar-2016	2	Text and formatting changes throughout document In Section 1: "Electrical ratings": - updated Table 4: "Avalanche characteristics" In Section 2: "Electrical characteristics" - updated Table 6: "Dynamic", Table 7: "Switching times" and Table 8: "Source drain diode" Added Section 2.1: "Electrical characteristics (curves)" Updated Section 4: "Package information"

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